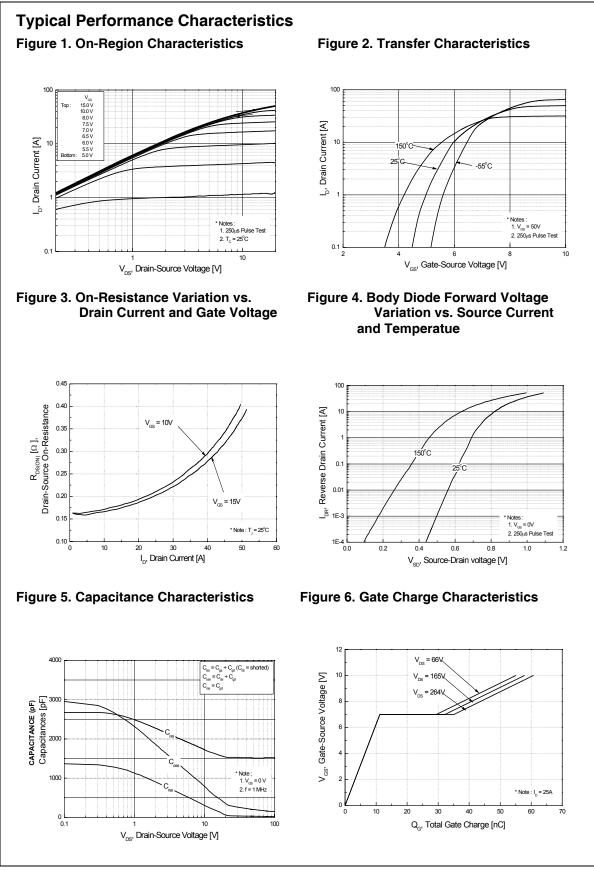
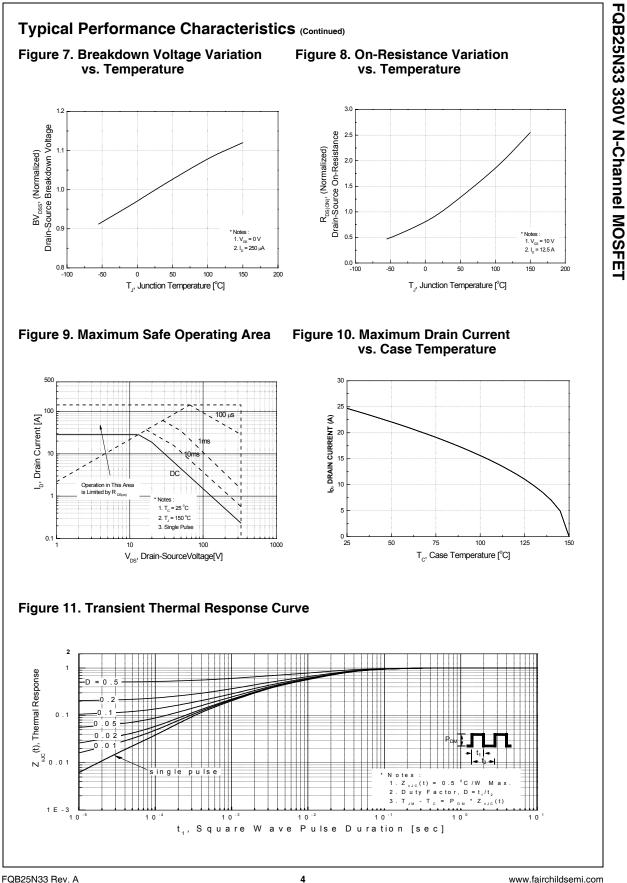
teristics	FQB25N33			Reel Size Tap				Quantity 800	
teristics	_	D2-PAł	K 330mm			24mm			
teristics	acteristics T	<sub>C</sub> = 25°C unle	ess otherw	ise noted					
	Symbol Parameter		Test Conditions		Min	Тур	Max	Units	
Drain-Source	Breakdown Volta	ge	I <sub>D</sub> = 250μ	A, V <sub>GS</sub> = 0	/	330			V
VDSS         Drain-Source Breakdown Voltage           VDSS/ ΔTJ         Breakdown Voltage Temperature Coefficient						0.34		V/ºC	
Zero Gate Voltage Drain Current		$V_{DS} = 330V, V_{GS} = 0V$ $V_{DS} = 264V, T_{C} = 125^{\circ}C$					1 10	μ <b>A</b>	
assr Gate-Body Leakage Current, Forward		orward						100	nA
Gate-Body Leakage Current, Forward           Gate-Body Leakage Current, Forward		$V_{GS} = -30V, V_{DS} = 0V$					-100	nA	
teristics			· · · ·		•	~ ~	1		
	-			-		3.0		5.0	V
									Ω
Forward Iran	sonductance		$V_{DS} = 50V, I_D = 12.5A, (Note 4)$				1		S
haracteristics									
Input Capacit	ance		$V_{DS} = 25V, V_{GS} = 0V,$ f = 1.0MHz		,		1510	2010	pF
Output Capad	citance				,		290	385	pF
Reverse Tran						40	60	pF	
Characteristics	3								
	v Timo					1			1
Turn-On Dela	y i me						20	35	ns
Turn-On Dela Turn-On Rise	,			5V, I <sub>D</sub> = 25A	4		20 100	35 160	ns ns
	Time		V <sub>DD</sub> = 16 R <sub>GS</sub> = 25	Ω	A (Note 4, 5)		-		-
Turn-On Rise	Time y Time		R <sub>GS</sub> = 25	Ω	(Note 4, 5)		100	160	ns
Turn-On Rise Turn-Off Dela Turn-Off Fall Total Gate Ch	Time y Time Time narge		R <sub>GS</sub> = 25 V <sub>DS</sub> = 29	Ω 7V, I <sub>D</sub> = 254	(Note 4, 5)		100 90	160 145	ns ns
Turn-On Rise Turn-Off Dela Turn-Off Fall Total Gate Ch	Time y Time Time		R <sub>GS</sub> = 25	Ω 7V, I <sub>D</sub> = 254	(Note 4, 5)		100 90 70	160 145 110	ns ns ns
Turn-On Rise Turn-Off Dela Turn-Off Fall Total Gate Ch	Time y Time Time harge ce Gate Charge		R <sub>GS</sub> = 25 V <sub>DS</sub> = 29	Ω 7V, I <sub>D</sub> = 25A V,	(Note 4, 5)	  	100 90 70 58	160 145 110 75	ns ns ns nC
Turn-On Rise Turn-Off Dela Turn-Off Fall Total Gate Cf Gate to Sourc Gate to Drain	Time y Time Time harge ce Gate Charge	aximum Ratin	R <sub>GS</sub> = 25 V <sub>DS</sub> = 29 V <sub>GS</sub> = 15	Ω 7V, I <sub>D</sub> = 25A V,	(Note 4, 5)	   	100 90 70 58 11.2	160 145 110 75 	ns ns nS nC nC
Turn-On Rise Turn-Off Dela Turn-Off Fall Total Gate Cf Gate to Sourd Gate to Drain ce Diode Cha	Time y Time Time harge ce Gate Charge Charge		$R_{GS} = 25$ $V_{DS} = 29$ $V_{GS} = 15$ gs	Ω 7V, I <sub>D</sub> = 25 <i>I</i> V,	(Note 4, 5)	   	100 90 70 58 11.2	160 145 110 75 	ns ns nS nC nC
Turn-On Rise Turn-Off Dela Turn-Off Fall Total Gate Cf Gate to Sourc Gate to Drain ce Diode Cha Maximum Co	Time y Time Time harge ce Gate Charge Charge racteristics and Ma	urce Diode Fo	$R_{GS} = 25$ $V_{DS} = 29$ $V_{GS} = 15$ gs prward Cur	Ω 7V, I <sub>D</sub> = 25A V, rrent	(Note 4, 5)	    	100 90 70 58 11.2 21	160 145 110 75  	ns ns nC nC nC
Turn-On Rise Turn-Off Dela Turn-Off Fall Total Gate Cl Gate to Sourc Gate to Drain ce Diode Cha Maximum Co Maximum Pu	Time y Time Time harge ce Gate Charge Charge racteristics and Ma ntinuous Drain-So	urce Diode Fo Diode Forwa	$R_{GS} = 25$ $V_{DS} = 29$ $V_{GS} = 15$ gs prward Cur	Ω 7V, I <sub>D</sub> = 25 <i>I</i> V, rrent	(Note 4, 5)	     	100 90 70 58 11.2 21	160 145 110 75   25	ns ns nC nC nC
Turn-On Rise Turn-Off Dela Turn-Off Fall Total Gate Cl Gate to Sourc Gate to Drain ce Diode Cha Maximum Co Maximum Pu	Time y Time Time harge ce Gate Charge Charge racteristics and Ma ntinuous Drain-So lsed Drain-Source Diode Forward Vo	urce Diode Fo Diode Forwa	$R_{GS} = 25$ $V_{DS} = 29$ $V_{GS} = 15$ gs prward Cur rd Current	Ω 7V, I <sub>D</sub> = 25A V, rrent	(Note 4, 5)	     	100 90 70 58 11.2 21 	160 145 110 75   25 100	ns ns nC nC nC A A
	Gate-Body Le Gate-Body Le eristics Gate Thresho Drain to Sourc Forward Tran haracteristics Input Capacit Output Capac Reverse Tran	Gate-Body Leakage Current, Fo Gate-Body Leakage Current, Fo eristics Gate Threshold Voltage Drain to Source On Resistance Forward Transonductance	Gate-Body Leakage Current, Forward Gate-Body Leakage Current, Forward eristics Gate Threshold Voltage Drain to Source On Resistance Forward Transonductance haracteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance	Zero Gate Voltage Drain Current $V_{DS} = 26$ Gate-Body Leakage Current, Forward $V_{GS} = 30$ Gate-Body Leakage Current, Forward $V_{GS} = -30$ eristics $V_{DS} = V_G$ Gate Threshold Voltage $V_{DS} = V_G$ Drain to Source On Resistance $V_{GS} = 10^{\circ}$ Forward Transonductance $V_{DS} = 50^{\circ}$ naracteristicsInput CapacitanceOutput Capacitance $V_{DS} = 25^{\circ}$ Reverse Transfer Capacitance $f = 1.0MH$	Zero Gate Voltage Drain Current $V_{DS} = 264V, T_C = 125$ Gate-Body Leakage Current, Forward $V_{GS} = 30V, V_{DS} = 0V$ Gate-Body Leakage Current, Forward $V_{GS} = -30V, V_{DS} = 0V$ eristicseristicsGate Threshold Voltage $V_{DS} = V_{GS}, I_D = 250\mu$ Drain to Source On Resistance $V_{GS} = 10V, I_D = 12.5\mu$ Forward Transonductance $V_{DS} = 50V, I_D = 12.5\mu$ naracteristicsInput CapacitanceOutput Capacitance $V_{DS} = 25V, V_{GS} = 0V$ Reverse Transfer Capacitance $f = 1.0MHz$	Zero Gate Voltage Drain Current $V_{DS} = 264V, T_C = 125^{\circ}C$ Gate-Body Leakage Current, Forward $V_{GS} = 30V, V_{DS} = 0V$ Gate-Body Leakage Current, Forward $V_{GS} = -30V, V_{DS} = 0V$ eristicseristicsGate Threshold Voltage $V_{DS} = V_{GS}, I_D = 250\mu A$ Drain to Source On Resistance $V_{GS} = 10V, I_D = 12.5A,$ Forward Transonductance $V_{DS} = 50V, I_D = 12.5A,$ (Note 4)maracteristicsInput CapacitanceOutput Capacitance $V_{DS} = 25V, V_{GS} = 0V,$ Reverse Transfer Capacitance $f = 1.0MHz$	Zero Gate Voltage Drain Current $V_{DS} = 264V, T_C = 125^{\circ}C$ Gate-Body Leakage Current, Forward $V_{GS} = 30V, V_{DS} = 0V$ Gate-Body Leakage Current, Forward $V_{GS} = -30V, V_{DS} = 0V$ eristics $V_{GS} = -30V, V_{DS} = 0V$ eristicsGate Threshold Voltage $V_{DS} = V_{GS}, I_D = 250\mu A$ 3.0Drain to Source On Resistance $V_{GS} = 10V, I_D = 12.5A,$ Forward Transonductance $V_{DS} = 50V, I_D = 12.5A,$ maracteristicsInput Capacitance $V_{DS} = 25V, V_{GS} = 0V,$ Output Capacitance $V_{DS} = 25V, V_{GS} = 0V,$ Reverse Transfer Capacitance $$	Zero Gate Voltage Drain Current $V_{DS} = 264V, T_C = 125^{\circ}C$ Gate-Body Leakage Current, Forward $V_{GS} = 30V, V_{DS} = 0V$ Gate-Body Leakage Current, Forward $V_{GS} = -30V, V_{DS} = 0V$ eristicsGate Threshold Voltage $V_{DS} = V_{GS}, I_D = 250\mu A$ $3.0$ Drain to Source On Resistance $V_{GS} = 10V, I_D = 12.5A,$ $0.18$ Forward Transonductance $V_{DS} = 50V, I_D = 12.5A,$ (Note 4)1naracteristicsInput Capacitance $V_{DS} = 25V, V_{GS} = 0V,$ $$ $1510$ Output Capacitance $V_{DS} = 25V, V_{GS} = 0V,$ $$ $290$ Reverse Transfer Capacitance $$ $40$	Zero Gate Voltage Drain Current $V_{DS} = 264V, T_C = 125^{\circ}C$ 10         Gate-Body Leakage Current, Forward $V_{GS} = 30V, V_{DS} = 0V$ 100         Gate-Body Leakage Current, Forward $V_{GS} = -30V, V_{DS} = 0V$ 100         Gate-Body Leakage Current, Forward $V_{GS} = -30V, V_{DS} = 0V$ 100         eristics       Gate Threshold Voltage $V_{DS} = V_{GS}, I_D = 250\mu A$ $3.0$ $5.0$ Drain to Source On Resistance $V_{GS} = 10V, I_D = 12.5A,$ $0.18$ $0.23$ Forward Transonductance $V_{DS} = 50V, I_D = 12.5A,$ (Note 4) $1$ naracteristics       Input Capacitance $V_{DS} = 25V, V_{GS} = 0V,$ $$ $1510$ $2010$ Output Capacitance $f = 1.0MHz$ $$ $40$ $60$

FQB25N33 330V N-Channel MOSFET

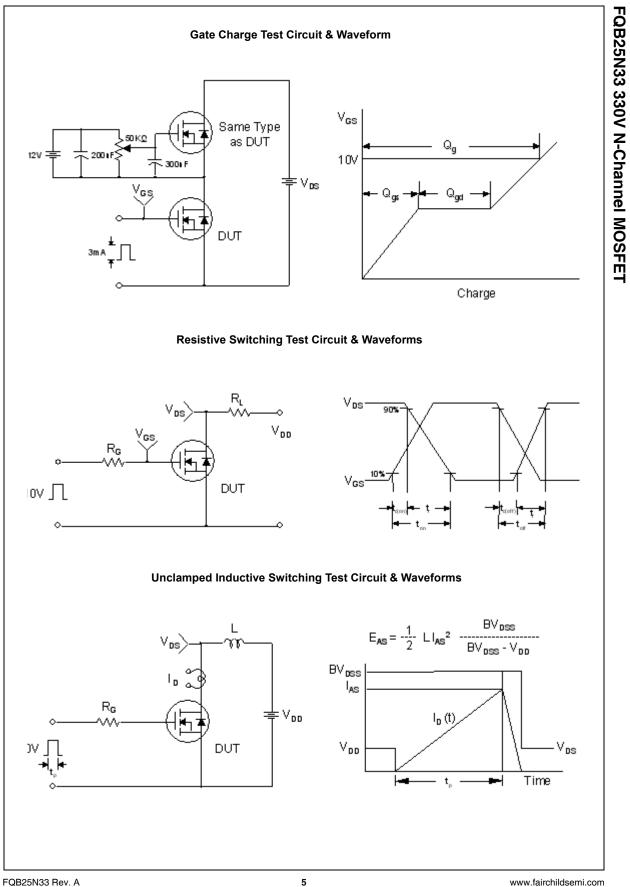


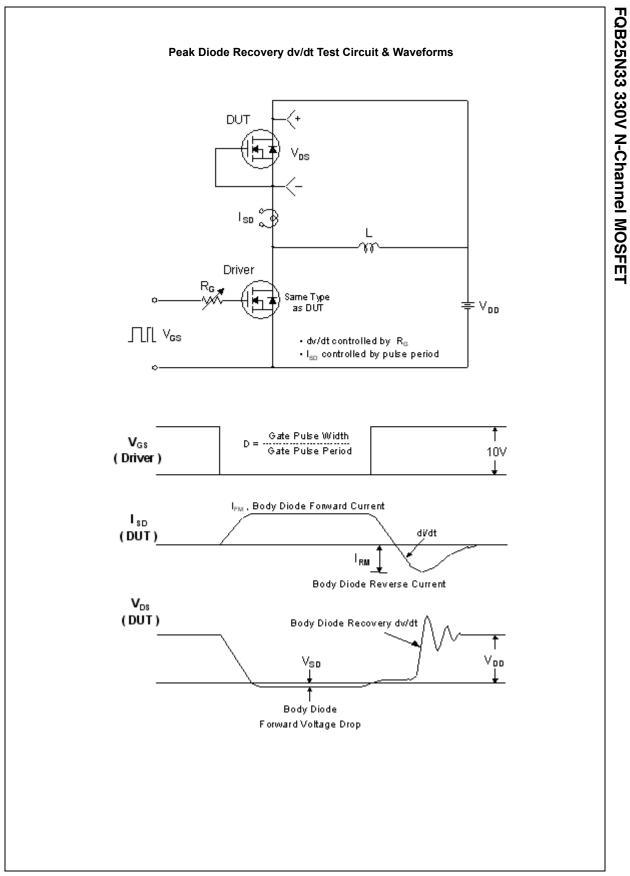
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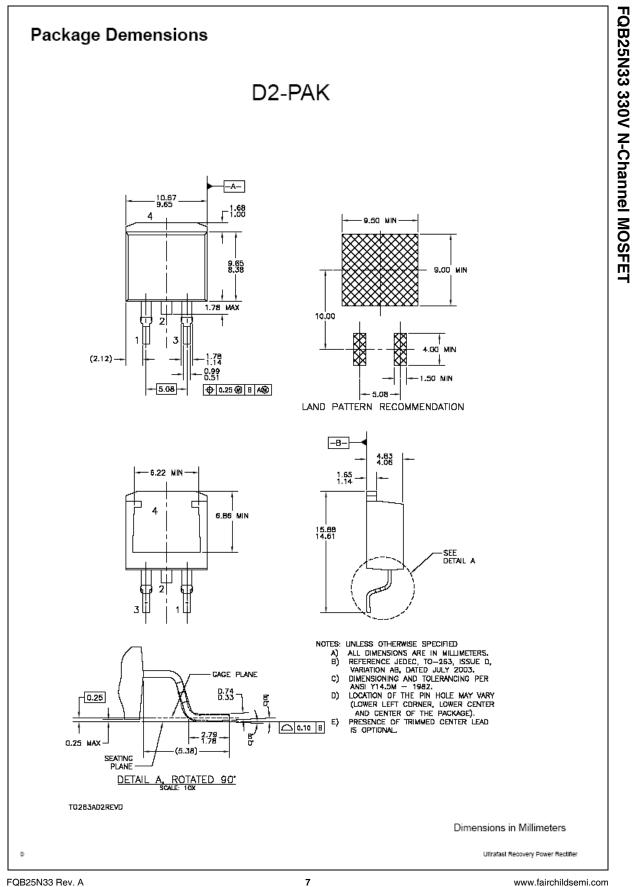


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UniFET™ **UltraFET**® VCX™ Wire™

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